

SN54HC377, SN74HC377 OCTAL D-TYPE FLIP-FLOPS WITH CLOCK ENABLE

SCLS307 – JANUARY 1996

- Eight Flip-Flops With Single-Rail Outputs
- Clock Enable Latched to Avoid False Clocking
- Applications Include:
 - Buffer/Storage Registers
 - Shift Registers
 - Pattern Generators
- Package Options Include Plastic Small-Outline (DW) and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

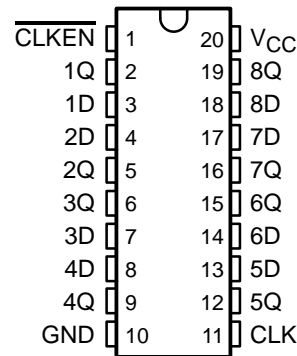
description

These devices are positive-edge-triggered octal D-type flip-flops with an enable input. The 'HC377 are similar to the 'HC273 but feature a latched clock-enable ($\overline{\text{CLKEN}}$) input instead of a common clear.

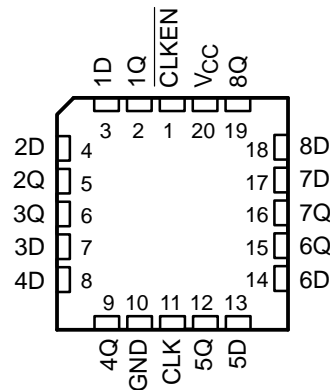
Information at the data (D) inputs meeting the setup time requirements is transferred to the Q outputs on the positive-going edge of the clock (CLK) pulse if $\overline{\text{CLKEN}}$ is low. Clock triggering occurs at a particular voltage level and is not directly related to the transition time of the positive-going pulse. When CLK is at either the high or low level, the D input has no effect at the output. These devices are designed to prevent false clocking by transitions at $\overline{\text{CLKEN}}$.

The SN54HC377 is characterized for operation over the full military temperature range of -55°C to 125°C . The SN74HC377 is characterized for operation from -40°C to 85°C .

SN54HC377 . . . J OR W PACKAGE
SN74HC377 . . . DW OR N PACKAGE
(TOP VIEW)



SN54HC377 . . . FK PACKAGE
(TOP VIEW)



FUNCTION TABLE
(each flip-flop)

| INPUTS | | | OUTPUT Q |
|---------------------------|------------|---|-------------|
| $\overline{\text{CLKEN}}$ | CLK | D | |
| H | X | X | Q_0 |
| L | \uparrow | H | H |
| L | \uparrow | L | L |
| X | L | X | Q_0 |



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

**TEXAS
INSTRUMENTS**

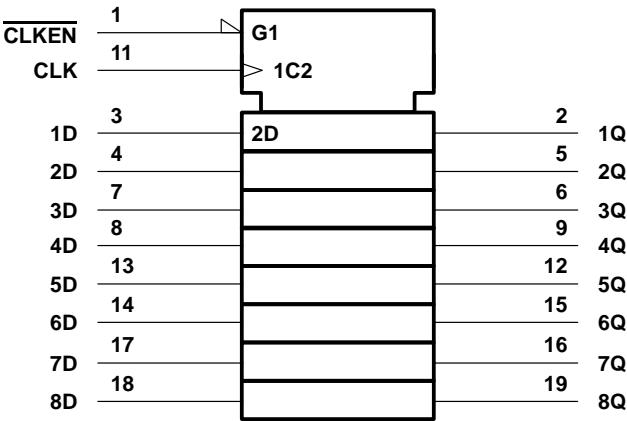
POST OFFICE BOX 655303 • DALLAS, TEXAS 75265

Copyright © 1996, Texas Instruments Incorporated

SN54HC377, SN74HC377
OCTAL D-TYPE FLIP-FLOPS
WITH CLOCK ENABLE

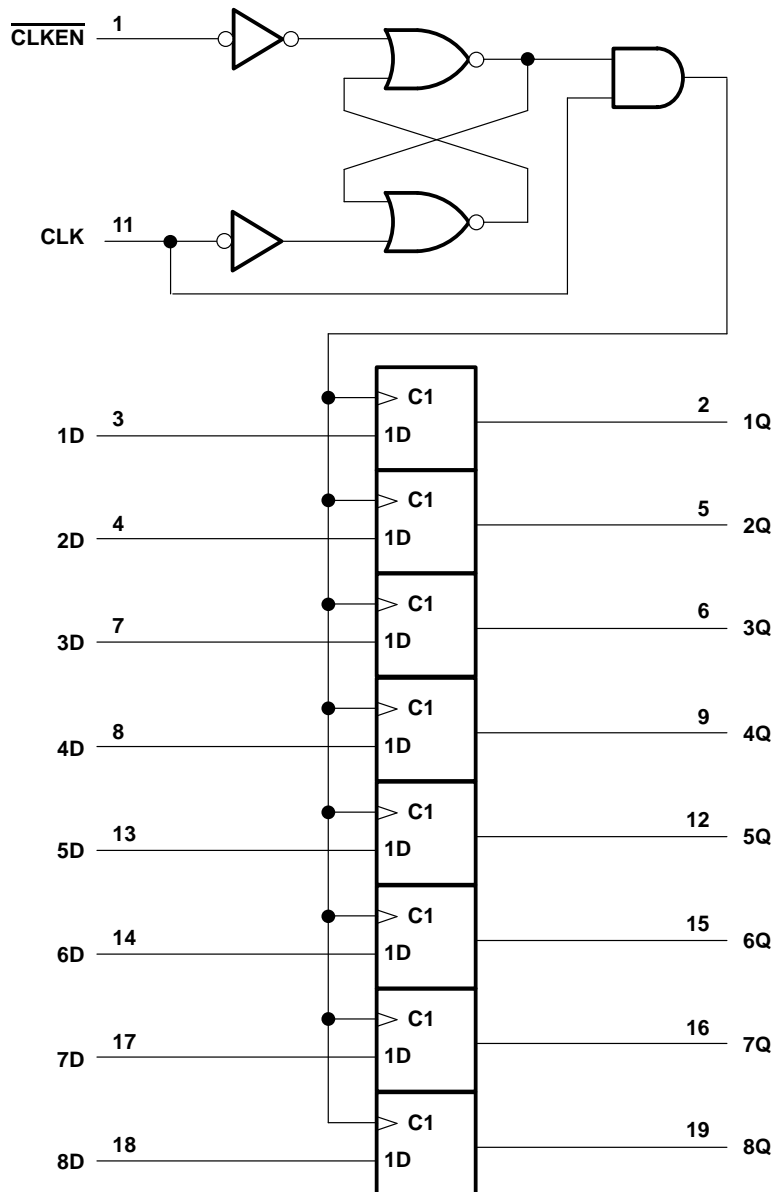
SCLS307 – JANUARY 1996

logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



SN54HC377, SN74HC377

OCTAL D-TYPE FLIP-FLOPS

WITH CLOCK ENABLE

SCLS307 – JANUARY 1996

absolute maximum ratings over operating free-air temperature range†

| | |
|---|----------------|
| Supply voltage range, V_{CC} | –0.5 V to 7 V |
| Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$) (see Note 1) | ±20 mA |
| Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$) (see Note 1) | ±20 mA |
| Continuous output current, I_O ($V_O = 0$ to V_{CC}) | ±25 mA |
| Continuous current through V_{CC} or GND | ±50 mA |
| Maximum power dissipation at $T_A = 55^\circ\text{C}$ (in still air) (see Note 2): DW package | 1.6 W |
| N package | 1.3 W |
| Storage temperature range, T_{stg} | –65°C to 150°C |

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
2. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils, except for the N package, which has a trace length of zero.

recommended operating conditions

| | | SN54HC377 | | | SN74HC377 | | | UNIT |
|----------|---------------------------------------|-------------------------|-----|----------|-------------------------|-----|----------|------|
| | | MIN | NOM | MAX | MIN | NOM | MAX | |
| V_{CC} | Supply voltage | 2 | 5 | 6 | 2 | 5 | 6 | V |
| V_{IH} | High-level input voltage | $V_{CC} = 2\text{ V}$ | | 1.5 | $V_{CC} = 2\text{ V}$ | | 1.5 | V |
| | | $V_{CC} = 4.5\text{ V}$ | | 3.15 | $V_{CC} = 4.5\text{ V}$ | | 3.15 | |
| | | $V_{CC} = 6\text{ V}$ | | 4.2 | $V_{CC} = 6\text{ V}$ | | 4.2 | |
| V_{IL} | Low-level input voltage | $V_{CC} = 2\text{ V}$ | | 0 | $V_{CC} = 2\text{ V}$ | | 0 | V |
| | | $V_{CC} = 4.5\text{ V}$ | | 0 | $V_{CC} = 4.5\text{ V}$ | | 0 | |
| | | $V_{CC} = 6\text{ V}$ | | 0 | $V_{CC} = 6\text{ V}$ | | 0 | |
| V_I | Input voltage | 0 | | V_{CC} | 0 | | V_{CC} | V |
| V_O | Output voltage | 0 | | V_{CC} | 0 | | V_{CC} | V |
| t_t | Input transition (rise and fall) time | $V_{CC} = 2\text{ V}$ | | 0 | $V_{CC} = 2\text{ V}$ | | 0 | ns |
| | | $V_{CC} = 4.5\text{ V}$ | | 0 | $V_{CC} = 4.5\text{ V}$ | | 0 | |
| | | $V_{CC} = 6\text{ V}$ | | 0 | $V_{CC} = 6\text{ V}$ | | 0 | |
| T_A | Operating free-air temperature | –55 | | 125 | –40 | | 85 | °C |

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | | V _{CC} | T _A = 25°C | | | SN54HC377 | | SN74HC377 | | UNIT |
|-----------------|---|---------------------------|-----------------|-----------------------|-------|------|-----------|-------|-----------|-------|------|
| | | | | MIN | TYP | MAX | MIN | MAX | MIN | MAX | |
| V _{OH} | V _I = V _{IH} or V _{IL} | I _{OH} = -20 µA | 2 V | 1.9 | 1.998 | | 1.9 | | 1.9 | | V |
| | | | 4.5 V | 4.4 | 4.499 | | 4.4 | | 4.4 | | |
| | | | 6 V | 5.9 | 5.999 | | 5.9 | | 5.9 | | |
| | | I _{OH} = -4 mA | 4.5 V | 3.98 | 4.3 | | 3.7 | | 3.84 | | |
| | | I _{OH} = -5.2 mA | 6 V | 5.48 | 5.8 | | 5.2 | | 5.34 | | |
| V _{OL} | V _I = V _{IH} or V _{IL} | I _{OL} = 20 µA | 2 V | | 0.002 | 0.1 | | 0.1 | | 0.1 | V |
| | | | 4.5 V | | 0.001 | 0.1 | | 0.1 | | 0.1 | |
| | | | 6 V | | 0.001 | 0.1 | | 0.1 | | 0.1 | |
| | | I _{OL} = 4 mA | 4.5 V | | 0.17 | 0.26 | | 0.4 | | 0.33 | |
| | | I _{OL} = 5.2 mA | 6 V | | 0.15 | 0.26 | | 0.4 | | 0.33 | |
| I _I | V _I = V _{CC} or 0 | | 6 V | | ±0.1 | ±100 | | ±1000 | | ±1000 | nA |
| I _{CC} | V _I = V _{CC} or 0, I _O = 0 | | 6 V | | | 8 | | 160 | | 80 | µA |
| C _i | | | 2 V to 6 V | | 3 | 10 | | 10 | | 10 | pF |

timing requirements over recommended operating free-air temperature range (unless otherwise noted)

| | | V _{CC} | T _A = 25°C | | SN54HC377 | | SN74HC377 | | UNIT |
|--------------------|---------------------------------|--------------------------------|-----------------------|-----|-----------|-----|-----------|-----|------|
| | | | MIN | MAX | MIN | MAX | MIN | MAX | |
| f _{clock} | Clock frequency | 2 V | 0 | 5 | 0 | 3 | 0 | 4 | MHz |
| | | 4.5 V | 0 | 25 | 0 | 16 | 0 | 20 | |
| | | 6 V | 0 | 29 | 0 | 19 | 0 | 23 | |
| t _w | Pulse duration, CLK high or low | 2 V | 100 | | 150 | | 125 | | ns |
| | | 4.5 V | 20 | | 30 | | 25 | | |
| | | 6 V | 17 | | 25 | | 21 | | |
| t _{su} | Setup time before CLK↑ | D | 2 V | 100 | 150 | | 125 | | ns |
| | | | 4.5 V | 20 | 30 | | 25 | | |
| | | | 6 V | 17 | 25 | | 21 | | |
| | CLKEN high or low | | 2 V | 100 | 150 | | 125 | | |
| | | | 4.5 V | 20 | 30 | | 25 | | |
| | | | 6 V | 17 | 25 | | 21 | | |
| t _h | Hold time after CLK↑ | CLKEN inactive or active, data | 2 V | 5 | 5 | | 5 | | ns |
| | | | 4.5 V | 5 | 5 | | 5 | | |
| | | | 6 V | 5 | 5 | | 5 | | |

SN54HC377, SN74HC377

OCTAL D-TYPE FLIP-FLOPS

WITH CLOCK ENABLE

SCLS307 – JANUARY 1996

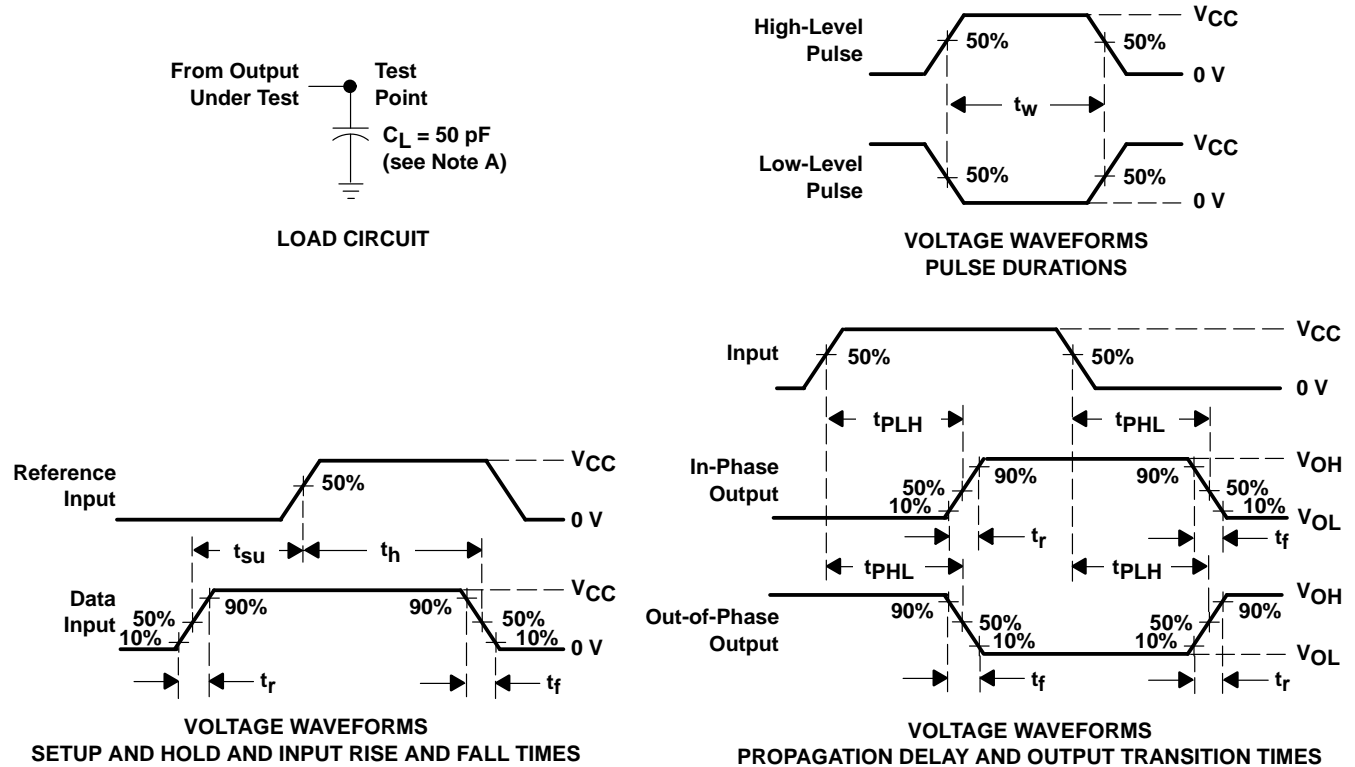
switching characteristics over recommended operating free-air temperature range, $C_L = 50$ pF (unless otherwise noted) (see Figure 1)

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | V_{CC} | $T_A = 25^\circ\text{C}$ | | | SN54HC377 | | SN74HC377 | | UNIT |
|------------|-----------------|----------------|----------|--------------------------|-----|-----|-----------|-----|-----------|-----|------|
| | | | | MIN | TYP | MAX | MIN | MAX | MIN | MAX | |
| f_{\max} | | | 2 V | 5 | 11 | | 3 | | 4 | | MHz |
| | | | 4.5 V | 25 | 54 | | 16 | | 20 | | |
| | | | 6 V | 29 | 64 | | 19 | | 23 | | |
| t_{pd} | CLK | Any | 2 V | | 56 | 160 | | 240 | | 200 | ns |
| | | | 4.5 V | | 15 | 32 | | 48 | | 40 | |
| | | | 6 V | | 12 | 27 | | 41 | | 34 | |
| t_t | | Any | 2 V | | 38 | 75 | | 110 | | 95 | ns |
| | | | 4.5 V | | 8 | 15 | | 22 | | 19 | |
| | | | 6 V | | 6 | 13 | | 19 | | 16 | |

operating characteristics, $T_A = 25^\circ\text{C}$

| PARAMETER | | TEST CONDITIONS | TYP | UNIT |
|-----------|---|-----------------|-----|------|
| C_{pd} | Power dissipation capacitance per flip-flop | No load | 30 | pF |

PARAMETER MEASUREMENT INFORMATION



- NOTES:
- A. C_L includes probe and test-fixture capacitance.
 - B. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: $PRR \leq 1 \text{ MHz}$, $Z_O = 50 \Omega$, $t_r = 6 \text{ ns}$, $t_f = 6 \text{ ns}$.
 - C. For clock inputs, f_{max} is measured when the input duty cycle is 50%.
 - D. The outputs are measured one at a time with one input transition per measurement.
 - E. t_{PLH} and t_{PHL} are the same as t_{pd} .

Figure 1. Load Circuit and Voltage Waveforms

IMPORTANT NOTICE

Texas Instruments (TI) reserves the right to make changes to its products or to discontinue any semiconductor product or service without notice, and advises its customers to obtain the latest version of relevant information to verify, before placing orders, that the information being relied on is current.

TI warrants performance of its semiconductor products and related software to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

Certain applications using semiconductor products may involve potential risks of death, personal injury, or severe property or environmental damage ("Critical Applications").

TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, INTENDED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT APPLICATIONS, DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS.

Inclusion of TI products in such applications is understood to be fully at the risk of the customer. Use of TI products in such applications requires the written approval of an appropriate TI officer. Questions concerning potential risk applications should be directed to TI through a local SC sales office.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards should be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance, customer product design, software performance, or infringement of patents or services described herein. Nor does TI warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used.